•	search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/799,384	SUN ET AL.	
Examiner	Art Unit	
Ylee	2613	

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	240.12 240.16 240.18 240.29	9/13/2005	YL
H04N	7/12		

TNI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEA	NOT RCH	ES STRATEGY)
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